# FAIRCHILD

SEMICONDUCTOR TM

# FQNL2N50B **500V N-Channel MOSFET**

#### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switch mode power supply, power factor correction, electronic lamp ballast based on half bridge.

#### Features

- 0.35A, 500V,  $R_{DS(on)}$  = 5.3 $\Omega$  @V\_{GS} = 10 V Low gate charge ( typical 6.0 nC)
- Low Crss (typical 4.0 pF)
- Fast switching
- Improved dv/dt capability



### Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQNL2N50B	Units	
V <sub>DSS</sub>	Drain-Source Voltage		500	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25	°C)	0.35	A	
	- Continuous (T <sub>C</sub> = 100°C)		0.22	А	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	1.4	А	
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V	
I <sub>AR</sub>	Avalanche Current	(Note 1)	0.35	А	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	0.15	mJ	
dv/dt	Peak Diode Recovery dv/dt	(Note 2)	4.5	V/ns	
P <sub>D</sub>	Power Dissipation ( $T_C = 25^{\circ}C$ )		1.5	W	
	- Derate above 25°C		0.012	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
TI	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C	
. ר			500		

## **Thermal Characteristics**

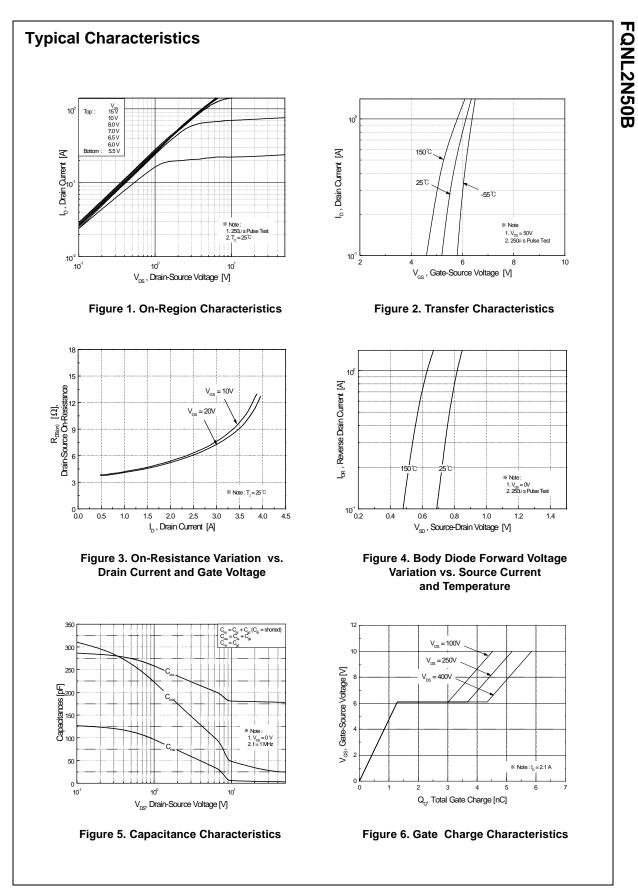
Symbol	Parameter	Тур	Max	Units
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction-to-Ambient		83	°C/W

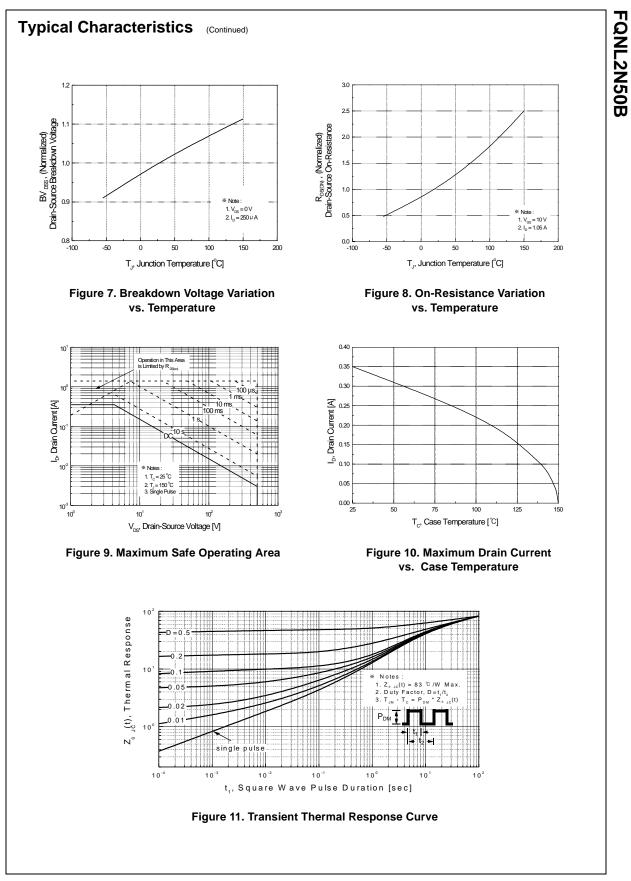
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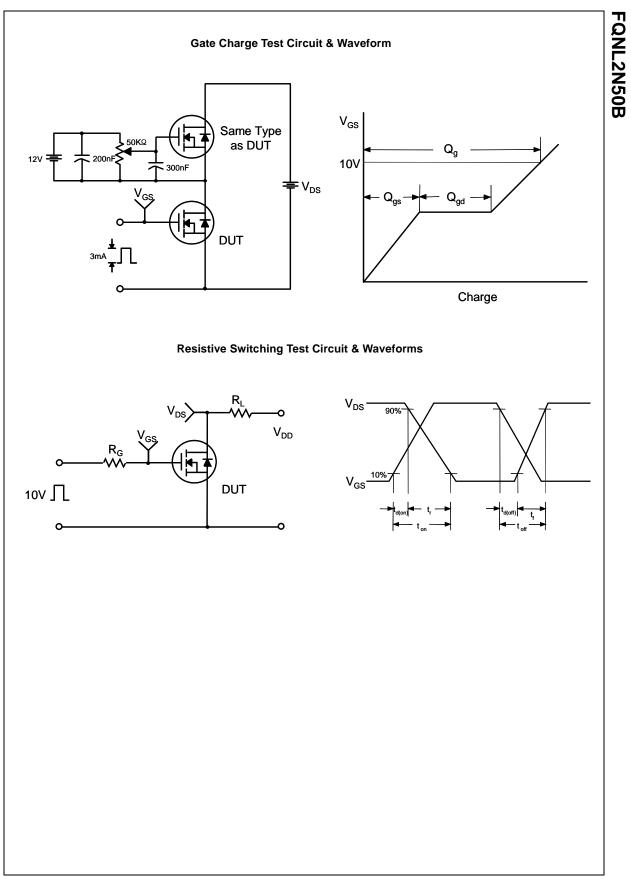
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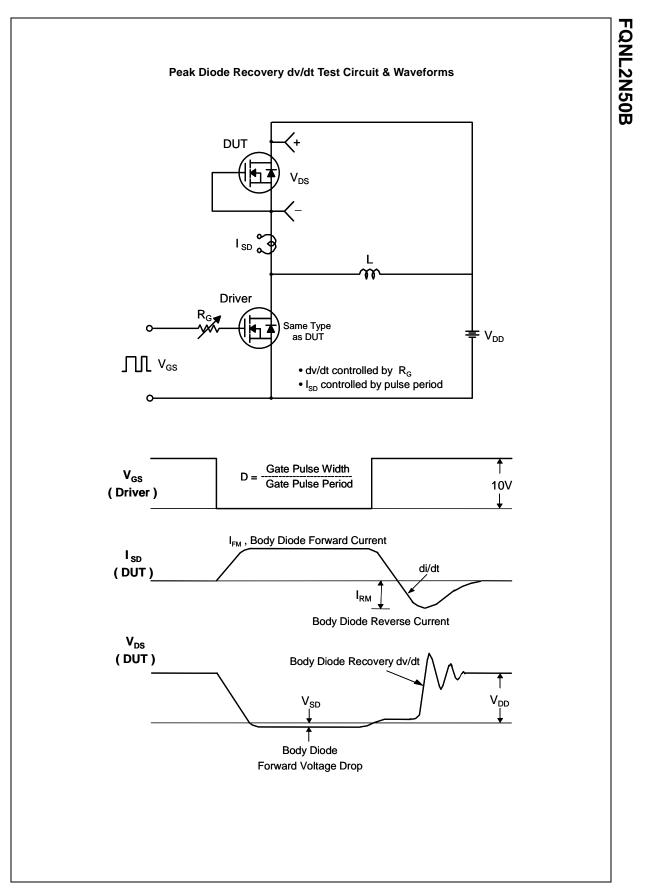
acteristics Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse acteristics	$V_{GS} = 0 \text{ V}, \text{ I}_{D} = 250 \mu\text{A}$ $I_{D} = 250 \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ $V_{DS} = 500 \text{V}, \text{V}_{GS} = 0 \text{V}$ $V_{DS} = 400 \text{V}, \text{T}_{C} = 125^{\circ}\text{C}$ $V_{GS} = 30 \text{V}, \text{V}_{DS} = 0 \text{V}$ $V_{GS} = -30 \text{V}, \text{V}_{DS} = 0 \text{V}$	500  	 0.48 		
Drain-Source Breakdown Voltage Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse	$I_{D} = 250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ $V_{DS} = 500 \ \text{V}, \ V_{GS} = 0 \ \text{V}$ $V_{DS} = 400 \ \text{V}, \ T_{C} = 125^{\circ}\text{C}$ $V_{GS} = 30 \ \text{V}, \ V_{DS} = 0 \ \text{V}$				
Breakdown Voltage Temperature Coefficient Zero Gate Voltage Drain Current Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse	$I_{D} = 250 \ \mu\text{A}, \text{ Referenced to } 25^{\circ}\text{C}$ $V_{DS} = 500 \ \text{V}, \ V_{GS} = 0 \ \text{V}$ $V_{DS} = 400 \ \text{V}, \ T_{C} = 125^{\circ}\text{C}$ $V_{GS} = 30 \ \text{V}, \ V_{DS} = 0 \ \text{V}$				V
Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse	$V_{DS} = 400 \text{ V}, T_{C} = 125^{\circ}\text{C}$ $V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$				V/°C
Gate-Body Leakage Current, Forward Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			1	μA
Gate-Body Leakage Current, Reverse				10	μΑ
	$V_{00} = -30 V V_{00} = 0 V$			100	nA
acteristics	*GS = 00 1, *DS = 0 1			-100	nA
Gate Threshold Voltage	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	2.3	3.0	3.7	V
Gale Theshold Voltage		-			V
Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 0.175 \text{ A}$		4.2	5.3	Ω
	$V_{DS} = 50 \text{ V}, I_{D} = 0.175 \text{ A}$ (Note 3)		0.72		S
			190	220	۳E
					pF
· · ·	f = 1.0 MHz				pF pF
Turn-On Delay Time Turn-On Rise Time	$V_{DD} = 250 \text{ V}, \text{ I}_{D} = 2.1 \text{ A},$		6 25	20 60	ns ns
Turn-Off Delay Time	NG - 20 22		10	20	ns
			10	30	
Turn-Off Fall Time	(Note 3, 4)		20	50	ns
Turn-Off Fall Time Total Gate Charge					ns nC
	V <sub>DS</sub> = 400 V, I <sub>D</sub> = 2.1 A,		20	50	
Total Gate Charge			20 6.0	50 8.0	nC
Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DS} = 400 \text{ V}, I_D = 2.1 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 3, 4)		20 6.0 1.3	50 8.0 	nC nC
Total Gate Charge Gate-Source Charge	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 2.1 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 3, 4) <b>nd Maximum Ratings</b>		20 6.0 1.3	50 8.0 	nC nC
Total Gate Charge Gate-Source Charge Gate-Drain Charge Purce Diode Characteristics ar	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 2.1 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 3, 4) <b>Add Maximum Ratings</b> add Forward Current		20 6.0 1.3 3.0	50 8.0  	nC nC nC
Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Purce Diode Characteristics ar</b> Maximum Continuous Drain-Source Dio	$V_{DS} = 400 \text{ V}, \text{ I}_{D} = 2.1 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 3, 4) <b>Add Maximum Ratings</b> add Forward Current		20 6.0 1.3 3.0	50 8.0   0.35	nC nC nC
Total Gate Charge Gate-Source Charge Gate-Drain Charge <b>Durce Diode Characteristics ar</b> Maximum Continuous Drain-Source Dio Maximum Pulsed Drain-Source Diode F	$V_{DS} = 400 \text{ V}, I_D = 2.1 \text{ A},$ $V_{GS} = 10 \text{ V}$ (Note 3, 4) <b>nd Maximum Ratings</b> ode Forward Current Forward Current		20 6.0 1.3 3.0  	50 8.0   0.35 1.4	nC nC nC A A
	On-Resistance Forward Transconductance Characteristics nput Capacitance Output Capacitance Reverse Transfer Capacitance g Characteristics Turn-On Delay Time Turn-On Rise Time	Dn-Resistance $V_{GS} = 10 \text{ V}, I_D = 0.175 \text{ A}$ Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 0.175 \text{ A}$ (Note 3)Characteristicsnput Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ Dutput Capacitance $f = 1.0 \text{ MHz}$ Reverse Transfer Capacitance $V_{DD} = 250 \text{ V}, I_D = 2.1 \text{ A},$ Turn-On Delay Time $V_{DD} = 250 \text{ Q}$	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, I_D = 0.175 \text{ A}$ Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 0.175 \text{ A}$ (Note 3)Characteristicsnput Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ Dutput Capacitance $f = 1.0 \text{ MHz}$ Reverse Transfer Capacitanceg CharacteristicsTurn-On Delay Time $V_{DD} = 250 \text{ V}, I_D = 2.1 \text{ A},$ Turn-On Rise Time $R_G = 25 \Omega$	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, I_D = 0.175 \text{ A}$ 4.2Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 0.175 \text{ A}$ (Note 3)0.72Characteristicsnput Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ 180Dutput Capacitance $f = 1.0 \text{ MHz}$ 30Reverse Transfer Capacitance4 <b>Gharacteristics</b> Turn-On Delay TimeTurn-On Rise Time $V_{DD} = 250 \text{ V}, I_D = 2.1 \text{ A},$ $R_G = 25 \Omega$ 25	Static Drain-Source On-Resistance $V_{GS} = 10 \text{ V}, I_D = 0.175 \text{ A}$ 4.2       5.3         Forward Transconductance $V_{DS} = 50 \text{ V}, I_D = 0.175 \text{ A}$ (Note 3) $0.72$ Characteristics        VDS = 25 V, VGS = 0 V, f = 1.0 MHz        180       230         Output Capacitance $V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz        180       230         Reverse Transfer Capacitance $f = 1.0 \text{ MHz}$ 30       40         Reverse Transfer Capacitance $r = 0.175 \text{ A}$ 4       6 <b>g Characteristics</b> $r = 0.175 \text{ A}$ $r = 0.72 \text{ A}$ 4       6         Turn-On Delay Time $V_{DD} = 250 \text{ V}, I_D = 2.1 \text{ A},$ $r = 0.20 \text{ C}$ 20        25       60

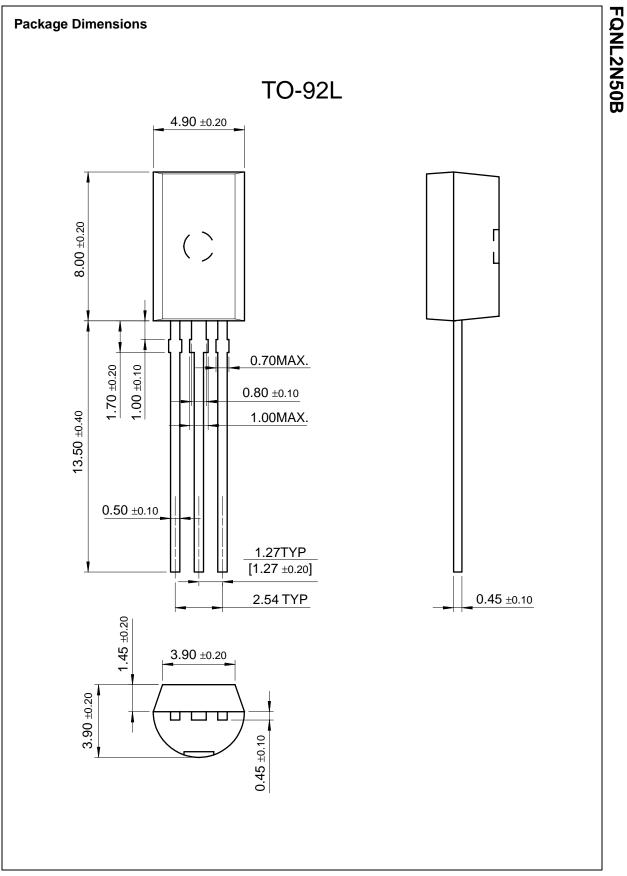
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#### **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

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<u>applications</u> <u>New products</u> <u>Product selection and</u> parametric search	These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.	This page <u>Print version</u>	Dotted line Quality and reliability Dotted line Design tools
Cross-reference search	This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and		
technical information	withstand high energy pulse in the avalanche and commutation mode. These devices are well		
buy products	suited for high efficiency switch mode power supply, power factor correction, electronic	-	
technical support my Fairchild	lamp ballast based on half bridge.		
company	back to top		

Features

• 0.35A, 500V,

 $R_{DS(on)} = 5.3\Omega @V_{GS} = 10 V$ 

- Low gate charge (typical 6.0 nC)
- Low Crss (typical 4.0 pF)
- Fast switching
- Improved dv/dt capability

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Product status/pricing/packaging

Product	Product status	Pricing*	Package type	Leads	Packing method
FQNL2N50BBU	Full Production	\$0.319	<u>TO-92</u>	3	BULK

TAPE REEL
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